



Advances in Scattering Imaging and Single-Pixel/Ghost Imaging

Guest Editor:

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Message from the Guest Editor

Currently, the areas involving scattering imaging and single-pixel/ghost imaging are developing rapidly. We are pleased to invite you to submit your papers to this Special Issue of *Photonics* entitled ‘Advances in Scattering Imaging and Single-Pixel/Ghost Imaging’ to share your latest research progress in this field.

This Special Issue welcomes original research articles, letters, brief communications, and reviews involving state-of-the-art optoelectronic imaging techniques. Topics of interest include, but are not limited to, the following:

- Imaging through scattering media;
- Super-resolution imaging through scattering media;
- Noninvasive imaging or tracking through scattering media;
- Imaging or measurements with a scattering lens;
- Single-pixel/ghost imaging;
- Single-pixel interferometry;
- Single-pixel holographic imaging;
- Single-pixel quantitative phase imaging;
- Single-pixel microscopy.

Looking forward to receiving your contributions.

